



TEST REPORT

No. I19D000117-SRD01

For

Client: Micronet

Production: A9 PCBA module

Model Name: A9

Brand Name: TREQ

FCC ID: U80-A9

IC ID: 12186A-A9

Hardware Version: C801_V1.00_PCB

Software Version: SC_10.2.0.0

Issued date: 2019-09-12

Page Number: 2 of 74

Report Issued Date: Sept.12, 2019



NOTE

- 1. The test results in this test report relate only to the devices specified in this report.
- 2. This report shall not be reproduced except in full without the written approval of East China Institute of Telecommunications.
- 3. For the test results, the uncertainty of measurement is not taken into account when judging the compliance with specification, and the results of measurement or the average value of measurement results are taken as the criterion of the compliance with specification directly.

Test Laboratory:

East China Institute of Telecommunications

Add: 7-8F, G Area, No.668, Beijing East Road, Huangpu District, Shanghai, P. R. China

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Revision Version

Report Number	Revision	Date	Memo
I19D00117-SRD01	00	2019-09-12	Initial creation of test report



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1. Test Laboratory

1.1. Testing Location

Company Name	East China Institute of Telecommunications
Address	7-8/F., Area G, No.668, Beijing East Road, Shanghai, China
Postal Code	200001
Telephone	+86 21 63843300
Fax	+86 21 63843301
FCC registration No	CN1177

1.2. Testing Environment

Normal Temperature	15°C-35°C
Relative Humidity	20%-75%

1.3. Project Data

Project Leader	Zhou Yan
Testing Start Date	2019-07-23
Testing End Date	2019-07-29

1.4. Signature

Wang Liang

(Prepared this test report)

Fan Songyan

(Reviewed this test report)

Zheng Zhongbin

(Approved this test report)



2. Client Information

2.1. Applicant Information

Company Name	Micronet
Address	1865 West 2100 South, Suite 2Salt Lake City, Utah 84119 United States
Telephone	+1-801-990-8700
Postcode	84119

2.2. Manufacturer Information

Company Name	Micronet
Address	1865 West 2100 South, Suite 2Salt Lake City, Utah 84119 United States
Telephone	+1-801-990-8700
Postcode	84119



3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Production	A9 PCBA module
Model name	A9
BT Frequency	2402MHz-2480MHz
BT Channel	Channel0-Channel78
BT type of modulation	GFSK/ π /4 DQPSK/8DPSK
Additional Communication Function	BT/BLE/2.4G WLAN 802.11 b/g/n20/n40/5G WLAN 802.11
Additional Communication Function	a/n20/n40/ac20/ac40
Extreme Temperature	-20/+70°C
Nominal Voltage	3.8V
Extreme High Voltage	4.2V
Extreme Low Voltage	3.7V
Maximum of Antenna Gain	Bluetooth: 6dBi

Note:

- a. Photographs of EUT are shown in ANNEX A of this test report.
- b. The value of the antenna gain is provided by the customer. For specific antenna information, please check the antenna specifications of the customer.

3.2.Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version	Date of receipt
N19	/	C801_V1.00_PCB	SC_10.2.0.0	2019-07-22
N20	/	C801_V1.00_PCB	SC_10.2.0.0	2019-07-22

^{*}EUT ID: is used to identify the test sample in the lab internally.

3.3.Internal Identification of AE used during the test

AE ID*	Description	Туре	Manufacturer
AE1	RF cable		AE1

^{*}AE ID: is used to identify the test sample in the lab internally.

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4. Reference Documents

4.1. Documents supplied by applicant

All technical documents are supplied by the client or manufacturer, which is the basis of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version	
	FCC CFR 47, Part 15, Subpart C:		
	15.205 Restricted bands of operation;		
FCC Part15	15.209 Radiated emission limits, general requirements; 2018-10		
	15.247 Operation within the bands 902-928MHz,		
	2400-2483.5MHz, and 5725-5850MHz.		
ANSI C63.10	American National Standard of Procedures for Compliance Testing of	2013	
ANSI C63.10	Unlicensed Wireless Devices		
	Guidance for Performing Compliance Measurements on		
KDB 558074	Frequency Hopping Spread Spectrum systems (DSS) Operating	v05r02	
	Under §15.247		
DSC 247	Digital Transmission Systems (DTSs), Frequency Hopping Systems	2017	
RSS-247	(FHSs) and Licence-Exempt Local Area Network (LE-LAN) Devices	2017	
RSS-Gen	General Requirements for Compliance of Radio Apparatus	2018	



5. Test Results

5.1. Summary of Test Results

Macaurament Itama	Sub-clause of	Sub-clause of	Verdict
Measurement Items	Part15C	IC	verdict
Maximum Book Output Bower	15 047/b)	RSS-247	Р
Maximum Peak Output Power	15.247(b)	5.4	r
20dB Occupied Randwidth	15.247(a)	RSS-247	Р
20dB Occupied Bandwidth	15.247 (a)	5.2	Г
Band Edges Compliance	15.247(b)	RSS-247	Р
Band Edges Compilance	15.247(b)	5.2	Г
Time Of Occupancy (Dwell Time)	(Dwell Time) 45 247(e)		Р
Time Of Occupancy (Dwell Time)	15.247(a)	5.5	Г
Carrier Frequency Separation	15 247(a)	RSS-247	Р
Carrier Frequency Separation	15.247(a)	5.2	Г
Number Of Hopping Channels	15.247(a) RSS-247		Р
Number Of Hopping Charmers	13.247 (a)	5.2	Г
Transmitter Spurious	15.247	RSS-247	Р
Emission-Conducted	13.247	5.2	Г
Transmitter Spurious	15.247,15.209,	RSS-247	Р
Emission-Radiated	13.247,13.209,	5.5	Г
AC Powerline Conducted Emission	Conducted Emission 15.107,15.207		Р
ACT OWEITING CONDUCTED ETHISSION	13.107,13.207	5.5	Г

Note: please refer to Annex A in this test report for the detailed test results.

The following terms are used in the above table.

Р	Pass, the EUT complies with the essential requirements in the standard.
NP	Not Perform, the test was not performed by ECIT.
NA	Not Applicable, the test was not applicable.
F	Fail, the EUT does not comply with the essential requirements in the standard.

Test Conditions

Tnom	Normal Temperature
Tmin	Low Temperature
Tmax	High Temperature
Vnom	Normal Voltage
Vmin	Low Voltage
Vmax	High Voltage
Hnom	Norm Humidity



Anom

For this report, all the test case listed above are tested under Normal Temperature and Normal Voltage, and also under norm humidity, the specific conditions as following:

Temperature	Tnom	25℃
Voltage	Vnom	3.8V
Humidity	Hnom	48%
Air Pressure	Anom	1010hPa

Note:

- a. All the test data for each data were verified, but only the worst case was reported.
- b.The GFSK, $\pi/4$ DQPSK and 8DPSK were set in DH1 for GFSK, 2-DH1 for $\pi/4$ DQPSK, 3-DH1 for 8DPSK.
- c.The DC and low frequency voltages' measurement uncertainty is ±2%.

5.2. Statements

The A9 is an initial product for testing.

ECIT only performed test cases which identified with P/NP/NA/F results in Annex A.

ECIT has verified that the compliance of the tested device specified in section 3 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 4 of this test report.



6. Test Equipments Utilized

6.1. Conducted Test System

Item	Instrument Name	Туре	SN	Manufacturer	Cal. Date	Cal. interval
1	Vector Signal Analyzer	FSQ26	101091	R&S	2019-05-10	1 year
2	DC Power Supply	ZUP60-14	LOC-220Z0 06-0007	TDL-Lambda	2019-05-10	1 year

6.2. Radiated Emission Test System

Item	Instrument Name	Туре	Serial Number	Manufacturer	Cal. Date	Cal.
1	Universal Radio Communication Tester	CMU200	123123	R&S	2019-05-10	1 year
2	EMI Test Receiver	ESU40	100307	R&S	2019-05-10	1 year
3	TRILOG Broadband Antenna	VULB9163	VULB9163- 515	Schwarzbeck	2017-02-25	3 years
4	Double- ridged Waveguide Antenna	ETS-3117	00135890	ETS	2017-01-11	3 years
5	2-Line V-Network	ENV216	101380	R&S	2019-05-10	1 year

Anechoic chamber

Fully anechoic chamber by ETS.

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7. Measurement Uncertainty

Measurement uncertainty for all the testing in this report are within the limit specified in ECIT documents . The detailed measurement uncertainty is defined in ECIT documents.

Measurement Items	Range	Confide nce Level	Calculated Uncertainty
Peak Output Power-Conducted	2402MHz-2480MHz	95%	\pm 0.544dB
Frequency Band Edges-Conducted	2402MHz-2480MHz	95%	±0.544dB
Conducted Emission	30MHz-2GHz	95%	\pm 0.90dB
Conducted Emission	2GHz-3.6GHz	95%	± 0.88 dB
Conducted Emission	3.6GHz-8GHz	95%	\pm 0.96dB
Conducted Emission	8GHz-20GHz	95%	± 0.94 dB
Conducted Emission	20GHz-22GHz	95%	± 0.88 dB
Conducted Emission	22GHz-26GHz	95%	±0.86dB
Transmitter Spurious Emission-Radiated	9KHz-30MHz	95%	±5.66dB
Transmitter Spurious Emission-Radiated	30MHz-1000MHz	95%	\pm 4.98dB
Transmitter Spurious Emission-Radiated	1000MHz -18000MHz	95%	±5.06dB
Transmitter Spurious Emission-Radiated	18000MHz -40000MHz	95%	\pm 5.20dB
Dwell Time	2402MHz-2480MHz	95%	\pm 0.218ms
20dB Bandwidth	2402MHz-2480MHz	95%	±62.04Hz
AC Power line Conducted Emission	0.15MHz-30MHz	95%	$\pm 3.66~\mathrm{dB}$



8. Test Environment

Shielding Room1 (6.0 meters×3.0 meters×2.7 meters) did not exceed following limits along the conducted RF performance testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	> 100 dB
Ground system resistance	< 0.5 Ω

Control room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. =30 %, Max. = 60 %
Shielding effectiveness	> 100 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω

Fully-anechoic chamber1 (6.9 meters×10.9 meters×5.4 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 25 %, Max. = 75 %
Shielding effectiveness	> 100 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
VSWR	Between 0 and 6 dB, from 1GHz to 18GHz
Site Attenuation Deviation	Between -4 and 4 dB,30MHz to 1GHz
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz



ANNEX A. Detailed Test Results

ANNEX A.1. Peak Output Power-Conducted

A.1.1 Measurement Limit

Standard	Limit (dBm)
FCC Part 15.247(b)(1)	< 30

A.1.2 Test Condition:

Hopping Mode	RBW	VBW	Span	Sweeptime
Hopping OFF	3MHz	10MHz	9MHz	Auto

A.1.3 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.5.

- 1. The output power of EUT was connected to the spectrum analyzer and CBT32 by cable and divide. The path loss was compensated to the results for each measurement.
- 2. Enable EUT transmitter maximum power continuously.
- 3. Measure the conducted output power and record the results it.

Measurement Results:

For GFSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted	6.39	6.99	5.87	
Output Power (dBm)	Fig.1	Fig.2	Fig.3	Р
EIRP(dBm)	12.39	12.99	11.87	

For $\pi/4$ DQPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted	6.04	6.63	5.49	
Output Power (dBm)	Fig.4	Fig.5	Fig.6	Р
EIRP(dBm)	12.04	12.63	11.49	

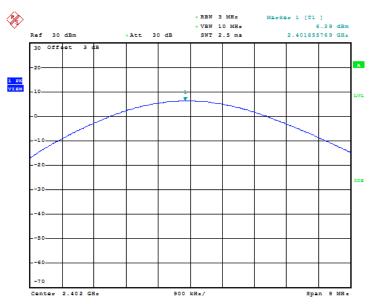
For 8DPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted	6.54	7.12	5.99	Р



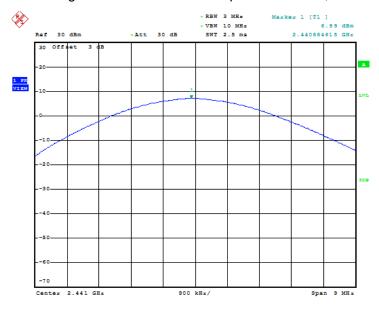
Output Power (dBm)	Fig.7	Fig.8	Fig.9
EIRP(dBm)	12.54	13.12	11.99

Conclusion: PASS
Test graphs an below



Date: 29.JUL.2019 06:52:09

Fig.1 Peak Conducted Output Power CH0, DH1



Date: 29.JUL.2019 06:53:20

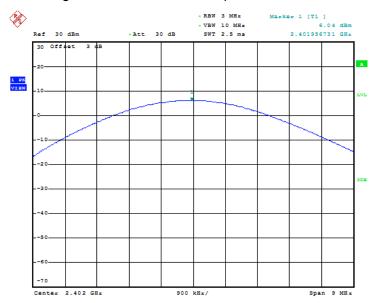
Fig.2 Peak Conducted Output Power CH39, DH1





Date: 29.JUL.2019 06:54:16

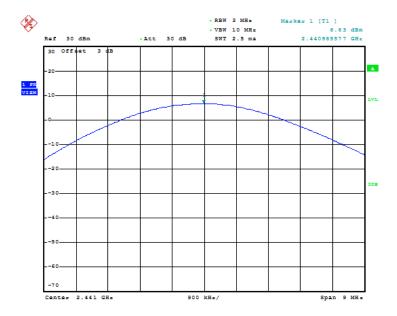
Fig.3 Peak Conducted Output Power CH78, DH1



Date: 29.JUL.2019 06:55:20

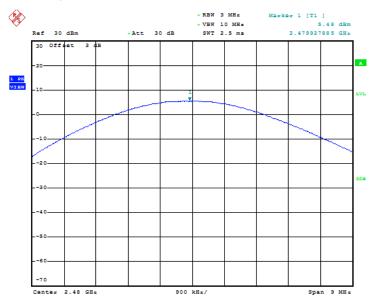
Fig.4 Peak Conducted Output Power CH0, 2DH1





Date: 29.JUL.2019 06:56:17

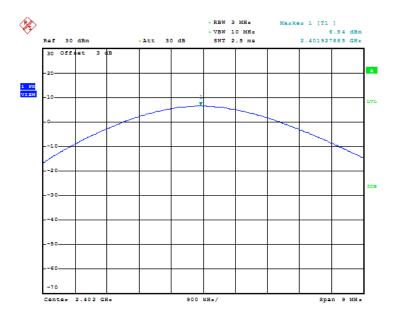
Fig.5 Peak Conducted Output Power CH39, 2DH1



Date: 29.JUL.2019 06:57:19

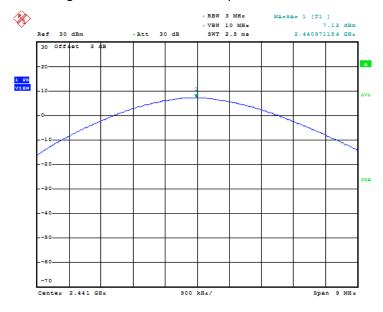
Fig.6 Peak Conducted Output Power CH78, 2DH1





Date: 29.JUL.2019 06:58:26

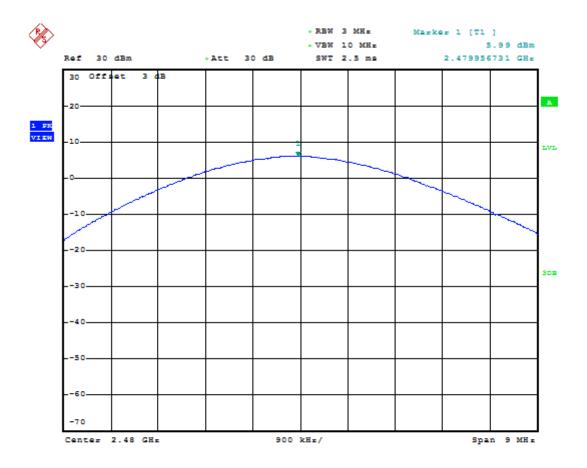
Fig.7 Peak Conducted Output Power CH0, 3DH1



Date: 29.JUL.2019 06:59:34

Fig.8 Peak Conducted Output Power CH39, 3DH1





Date: 29.JUL.2019 07:01:31

Fig.9 Peak Conducted Output Power CH78, 3DH1



ANNEX A.2. Frequency Band Edges-Conducted

A.2.1 Measurement Limit:

Standard	Limited(dBc)
FCC 47 CFR Part 15.247(d)	>20

A.2.2 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.6.

- 1. Connect the EUT to spectrum analyzer.
- 2. Set RBW=100KHz, VBW=300KHz, span more than 1.5 times channel bandwidth (2MHz).
- 3. Detector =peak, sweep time=auto couple, trace mode=max hold.
- 4. Allow sweep to continue until the trace stabilizes.

Measurement results

For GFSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.10	Р
0	Hopping ON	Fig.11	Р
78	Hopping OFF	Fig.12	Р
	Hopping ON	Fig.13	Р

For π/4 DQPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.14	Р
0	Hopping ON	Fig.15	Р
70	Hopping OFF	Fig.16	Р
78	Hopping ON	Fig.17	Р

For 8DPSK



Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.18	Р
0	Hopping ON	Fig.19	Р
70	Hopping OFF	Fig.20	Р
78	Hopping ON	Fig.21	Р

Conclusion: PASS
Test graphs an below

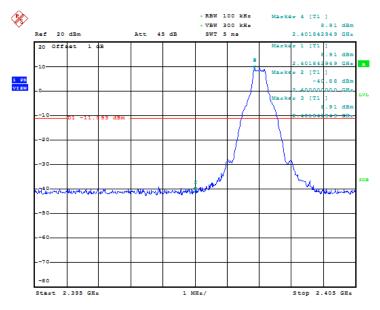
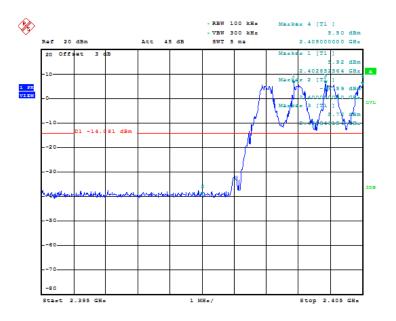


Fig.10 Frequency Band Edge: GFSK, Ch0, Hopping OFF

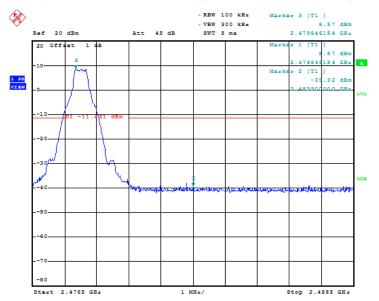
Date: 23.JUL.2019 04:32:07





Date: 29.JUL.2019 07:51:31

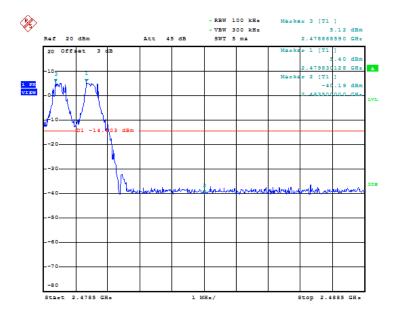
Fig.11 Frequency Band Edge: GFSK, Ch0, Hopping ON



Date: 23.JUL.2019 04:41:18

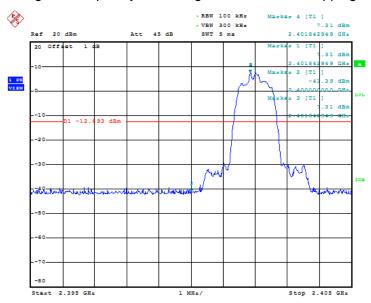
Fig.12 Frequency Band Edge: GFSK, Ch78, Hopping OFF





Date: 29.JUL.2019 08:07:27

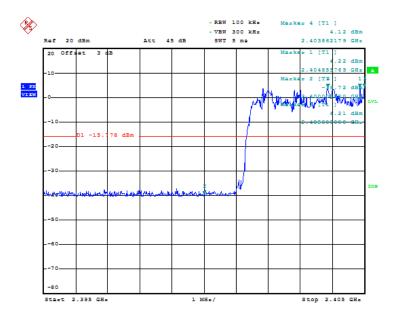
Fig.13 Frequency Band Edge: GFSK, Ch78, Hopping ON



Date: 23.JUL.2019 04:44:29

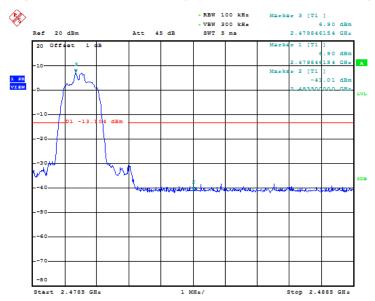
Fig.14 Frequency Band Edge: π/4 DQPSK, Ch0, Hopping OFF





Date: 29.JUL.2019 07:54:41

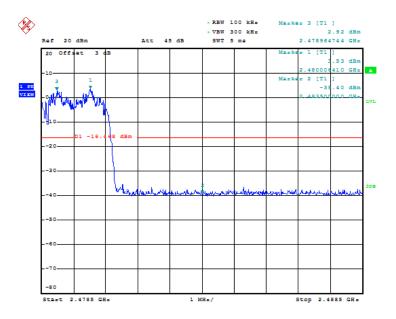
Fig.15 Frequency Band Edge: π/4 DQPSK, Ch0, Hopping ON



Date: 23.JUL.2019 04:51:08

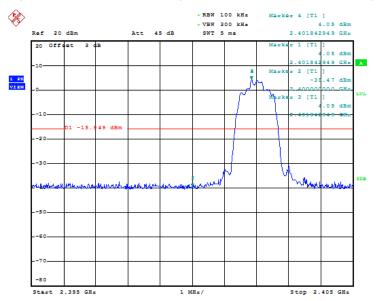
Fig.16 Frequency Band Edge: π/4 DQPSK, Ch78, Hopping OFF





Date: 29.JUL.2019 08:09:43

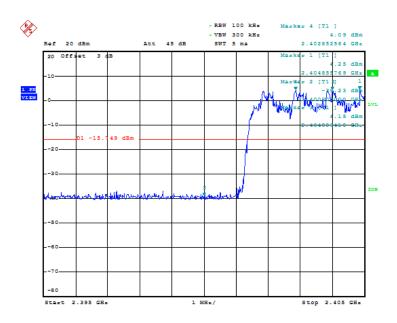
Fig.17 Frequency Band Edge: $\pi/4$ DQPSK, Ch78, Hopping ON



Date: 29.JUL.2019 07:41:14

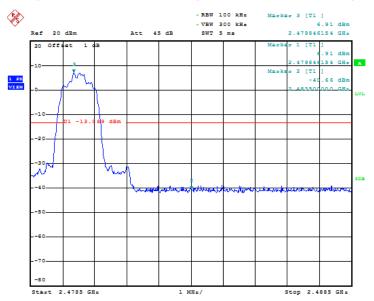
Fig.18 Frequency Band Edge: 8DPSK, Ch0, Hopping OFF





Date: 29.JUL.2019 07:57:42

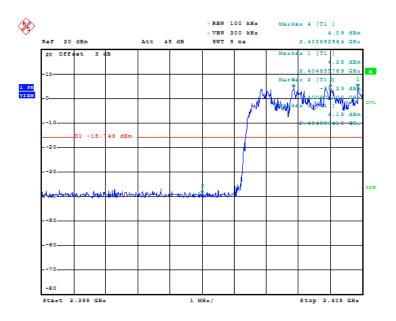
Fig.19 Frequency Band Edge: 8DPSK, Ch0, Hopping ON



Date: 23.JUL.2019 05:04:11

Fig.20 Frequency Band Edge: 8DPSK, Ch78, Hopping OFF





Date: 29.JUL.2019 07:57:42

Fig.21 Frequency Band Edge: 8DPSK, Ch78, Hopping ON



ANNEX A.3. Conducted Emission

A.3.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part15.247 (d)	20dB below peak output power in 100KHz bandwidth

A.3.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.8.

- 1. Connect the EUT to spectrum analyzer.
- 2. Set RBW=100KHz, VBW=300KHz.
- 3. Detector =peak, sweep time=auto couple, trace mode=max hold.

Measurement Results:

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~26GHz	Fig.22	Р
Ch39 2441MHz	30MHz~26GHz	Fig.23	Р
Ch78 2480MHz	30MHz~26GHz	Fig.24	Р

For $\pi/4$ DQPSK

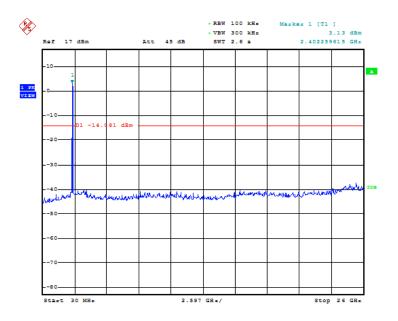
Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~26GHz	Fig.25	Р
Ch39 2441MHz	30MHz~26GHz	Fig.26	Р
Ch78 2480MHz	30MHz~26GHz	Fig.27	Р

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~26GHz	Fig.28	Р
Ch39 2441MHz	30MHz~26GHz	Fig.29	Р
Ch78 2480MHz	30MHz~26GHz	Fig.30	Р

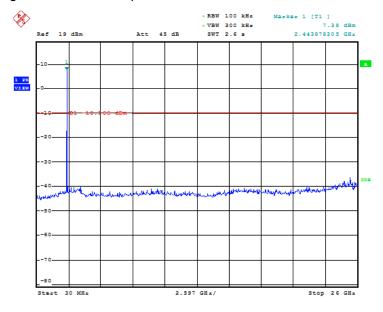
Conclusion: PASS
Test graphs as below





Date: 29.JUL.2019 07:52:44

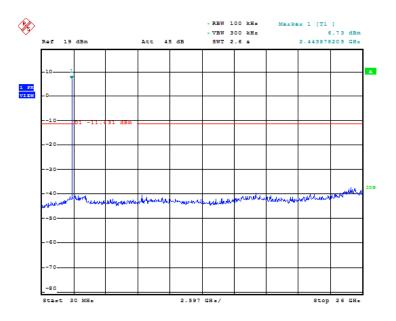
Fig.22 Conducted spurious emission: GFSK, Ch0, 30MHz~26GHz



Date: 23.JUL.2019 04:39:24

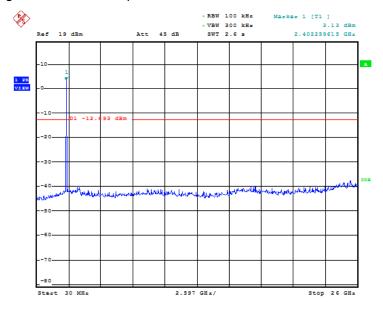
Fig.23 Conducted spurious emission: GFSK, Ch39, 30MHz~26GHz





Date: 23.JUL.2019 04:42:30

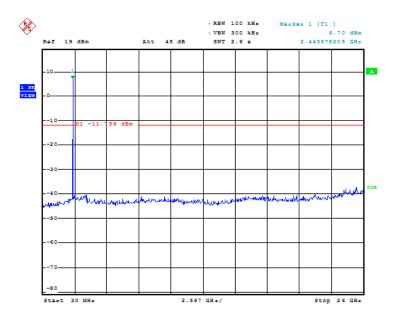
Fig.24 Conducted spurious emission: GFSK, Ch78, 30MHz~26GHz



Date: 23.JUL.2019 04:45:41

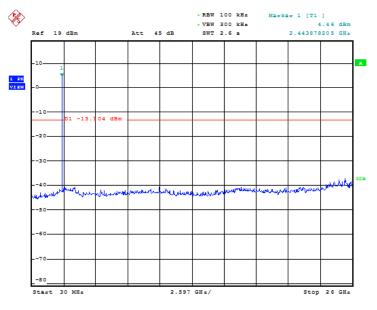
Fig.25 Conducted spurious emission: $\pi/4$ DQPSK, Ch0, 30MHz~26GHz





Date: 23.JUL.2019 04:49:19

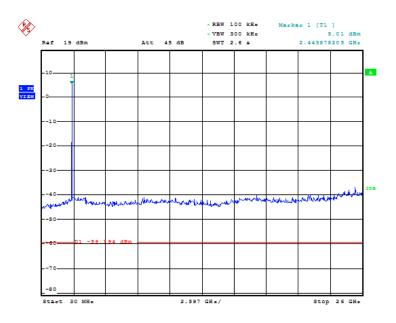
Fig.26 Conducted spurious emission: π/4 DQPSK, Ch39, 30MHz~26GHz



Date: 23.JUL.2019 04:52:20

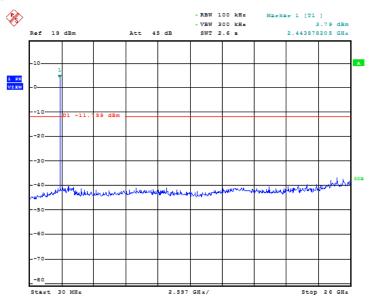
Fig.27 Conducted spurious emission: $\pi/4$ DQPSK, Ch78, 30MHz~26GHz





Date: 23.JUL.2019 04:55:24

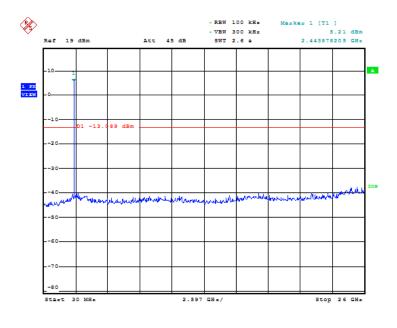
Fig.28 Conducted spurious emission: 8DPSK, Ch0, 30MHz~26GHz



Date: 23.JUL.2019 05:02:06

Fig.29 Conducted spurious emission: 8DPSK, Ch39, 30MHz~26GHz





Date: 23.JUL.2019 05:05:23

Fig.30 Conducted spurious emission: 8DPSK, Ch78, 30MHz~26GHz



ANNEX A.4. Radiated Emission

A.4.1 Measurement Limit:

Standard	Limit	
FCC 47 CFR Part 15.247, 15.205, 15.209	20dB below peak output power	

In addition, radiated emissions which fall in the restricted bands, as defined in 15.205(a), must also comply with the radiated emission limits specified in 15.209(a) (see 15.205(c)).

Limit in restricted band:

Frequency of emission (MHz)	Field strength (uV/m)	Field strength (dBuV/m)
30~88	100	40
88~216	150	43.5
216~960	200	46
Above 960	500	54

A.4.2 Test Method

Portable, small, lightweight, or modular devices that may be handheld, worn on the body, or placed on a table during operation shall be positioned on a non-conducting platform, the top of which is 80 cm above the reference ground plane. The preferred area occupied by the EUT arrangement is 1 m by 1.5 m, For emissions testing at or below 1 GHz, the table height shall be 80 cm above the reference ground plane. For emission measurements above 1 GHz, the table height shall be 1.5 m. but it may be larger or smaller to accommodate various sized EUTs. For testing purposes, ceiling- and wall-mounted devices also shall be positioned on a tabletop (see also ANSI C63.10-2013 section 6.3.4 and 6.3.5). In making any tests involving handheld, body-worn, or ceiling-mounted equipment, it is essential to recognize that the measured levels may be dependent on the orientation (attitude) of the three orthogonal axes of the EUT. Thus, exploratory tests as specified in 8.3.1 shall be carried out for various axes orientations to determine the attitude having maximum or near-maximum emission level.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

Frequency of emission (MHz)	RBW/VBW	Sweep Time (s)
30~1000	100KHz/300KHz	5
1000~4000	1MHz/3MHz	15
4000~18000	1MHz/3MHz	40
18000~26500	1MHz/3MHz	20



A.4.3 Measurement Results:

A "reference path loss" is established and A_{Rpi} is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss.

The measurement results are obtained as described below:

A_{Rpi} = Cable loss + Antenna Gain-Preamplifier gain

Result= $P_{Mea} + A_{Rpi}$

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MH~1GHz	Fig.31	Р
	1GHz~3GHz	Fig.32	Р
	3GHz~18GHz	Fig.33	Р
Bandedge (low)	2.31GHz~2.5GHz	Fig.34	Р
Bandedge (high)	2.31GHz~2.5GHz	Fig.35	Р

For $\pi/4$ DQPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MH~1GHz	Fig.36	Р
	1GHz~3GHz	Fig.37	Р
	3GHz~18GHz	Fig.38	Р
Bandedge (low)	2.31GHz~2.5GHz	Fig.39	Р
Bandedge (high)	2.31GHz~2.5GHz	Fig.40	Р

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MH~1GHz	Fig.41	Р
	1GHz~3GHz	Fig.42	Р
	3GHz~18GHz	Fig.43	Р
Bandedge (low)	2.31GHz~2.5GHz	Fig.44	Р
Bandedge (high)	2.31GHz~2.5GHz	Fig.45	Р



GFSK Ch0 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl(dB)	PMea(dBuV/m)	Polarity
35.8	17.45	-27.2	44.65	V
75.2	17.43	-30.9	48.33	V
108.1	15.1	-27.2	42.3	Н
168.0	23.86	-29.6	53.46	Н
240.4	26.7	-26.9	53.6	V
529.3	24.63	-21.3	45.93	V

GFSK Ch0 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl(dB)	PMea(dBuV/m)	Polarity
2550.5	53.83	3.5	50.33	V
2652.6	54.43	4.4	50.03	V
2764.6	54.11	4.3	49.81	V
2811.5	55.05	4.5	50.55	Н
2894.5	55.12	5.8	49.32	V
2936.4	55.35	5.5	49.85	Н

GFSK Ch0 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl(dB)	PMea(dBuV/m)	Polarity
2652.6	42.11	4.4	37.71	V
2764.6	42.12	4.3	37.82	V
2811.5	42.31	4.5	37.81	Н
2894.5	43.41	5.8	37.61	V
2936.4	43.17	5.5	37.67	Н

GFSK Ch0 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14748.4	54.73	20.8	33.93	Н
15742.3	56.81	23.2	33.61	Н



15994.4	59.87	25.4	34.47	V
16462.7	59.55	25.8	33.75	Н
17105.5	59.05	26.9	32.15	Н
17685.5	59.78	27.2	32.58	V

GFSK Ch0 3GHz-18GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14748.4	42.74	20.8	21.94	Н
15742.3	44.13	23.2	20.93	Н
15994.4	47.02	25.4	21.62	V
16462.7	45.93	25.8	20.13	Н
17105.5	47.52	26.9	20.62	Н
17685.5	47.11	27.2	19.91	V

π/4 DQPSK Ch0 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
34.7	18.41	-27.5	45.91	V
47.4	23.46	-25.3	48.76	V
137.1	18.51	-30.9	49.41	Н
245.7	28.58	-26.8	55.38	V
530.8	27.09	-21.3	48.39	Н
657.2	26.13	-18.6	44.73	Н

π/4 DQPSK Ch0 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2560.0	54.19	3.6	50.59	V
2663.5	54.31	4.5	49.81	V
2776.7	54.67	4.3	50.37	V
2836.7	56.12	4.9	51.22	Н



2883.4	55.46	5.6	49.86	Н
2958.9	55.77	5.4	50.37	V

$\pi/4$ DQPSK Ch0 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2560.0	41.49	3.6	37.89	V
2663.5	42.32	4.5	37.82	V
2776.7	42.06	4.3	37.76	V
2836.7	42.48	4.9	37.58	Н
2883.4	43.22	5.6	37.62	Н

π/4 DQPSK Ch0 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14301.6	55.39	20.8	34.59	Н
14862.2	55.19	20.5	34.69	Н
15435.3	56.36	22.7	33.66	Н
16018.5	59.04	25.3	33.74	Н
16802.1	59.16	27.2	31.96	V
17583.1	59.72	27.7	32.02	Н

π/4 DQPSK Ch0 3GHz-18GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14301.6	42.76	20.8	21.96	Н
14862.2	42.69	20.5	22.19	Н
15435.3	43.99	22.7	21.29	Н
16018.5	46.91	25.3	21.61	Н
16802.1	47.45	27.2	20.25	V
17583.1	47.76	27.7	20.06	Н



8DPSK Ch0 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
35.1	17.49	-27.4	44.89	V
74.5	17.82	-30.7	48.52	Н
168.0	21.78	-29.6	51.38	Н
243.8	27.82	-26.9	54.72	V
530.8	24.6	-21.3	45.9	V
656.5	27.43	-18.6	46.03	Н

8DPSK Ch0 1GHz-3GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2551.2	53.36	3.5	49.86	V
2659.1	54.18	4.4	49.78	V
2739.4	54.47	4.3	50.17	Н
2793.2	54.94	4.4	50.54	Н
2873.9	55.49	5.4	50.09	V
2948.4	54.62	5.4	49.22	V

8DPSK Ch0 1GHz-3GHz (Average)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2659.1	42.31	4.4	37.91	V
2739.4	42.03	4.3	37.73	Н
2793.2	42.18	4.4	37.78	Н
2873.9	43.02	5.4	37.62	V
2948.4	42.78	5.4	37.38	V
2659.1	42.31	4.4	37.91	V

8DPSK Ch0 3GHz-18GHz (Peak)

Frequency(MHz)	Result(dBuV/m)	ARpl (dB) PMea(dBuV/m)		Polarity
5995.2	46.95	2.3	44.65	V



12876.5	52.71	16.9	35.81	н
13653.0	53.07	17.8	35.27	Н
14736.3	54.57	20.9	33.67	Н
15716.2	56.96	23.2	33.76	V
16772.2	60.08	26.8	33.28	V

8DPSK Ch0 3GHz-18GHz (Average)

Frequency(MHz)	Result(dBuV/m)	Result(dBuV/m) ARpl (dB) PMea(dBuV/		Polarity
14736.3	42.83	20.9	21.93	Н
15716.2	44.54	23.2	21.34	V
16772.2	47.3	26.8	20.5	V

Note: Only the worst case is written in the report.

Conclusion: PASS
Test graphs as below:

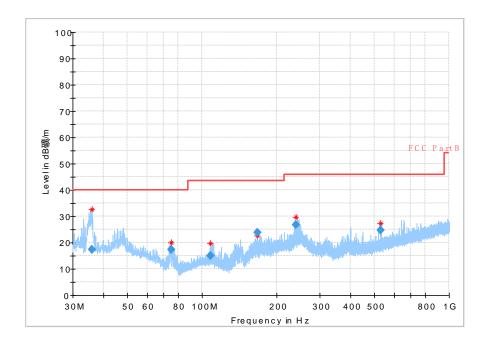


Fig.31 Radiated emission: GFSK, Ch0, 30MHz~1GHz



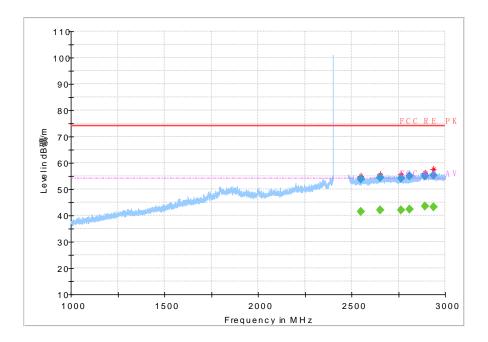


Fig.32 Radiated emission: GFSK, Ch0, 1GHz~3GHz

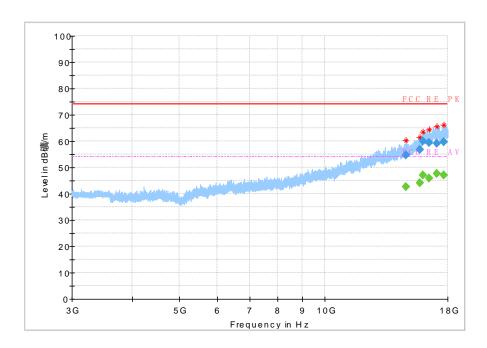


Fig.33 Radiated emission: GFSK, Ch0, 3GHz~18GHz



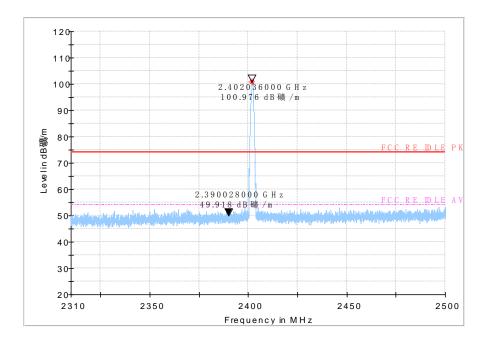


Fig.34 Bandedge (Low): GFSK, low channel

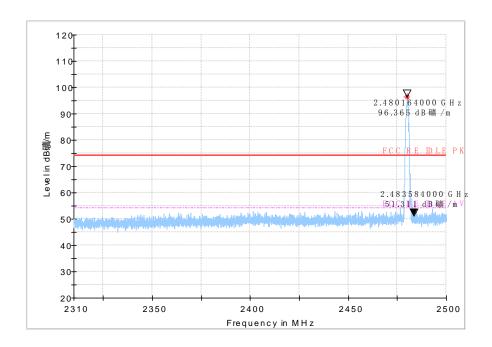


Fig.35 Bandedge (High): GFSK, high channel



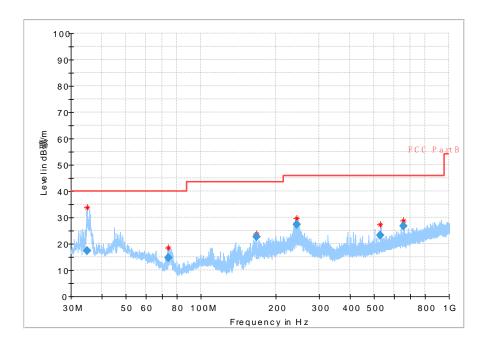


Fig.36 Radiated emission: $\pi/4$ DQPSK, Ch0, 30MHz~1GHz

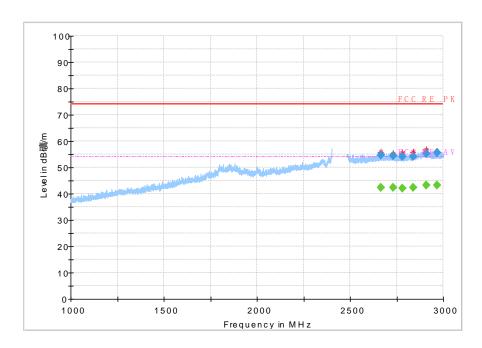


Fig.37 Radiated emission: π/4 DQPSK, Ch0, 1GHz~3GHz



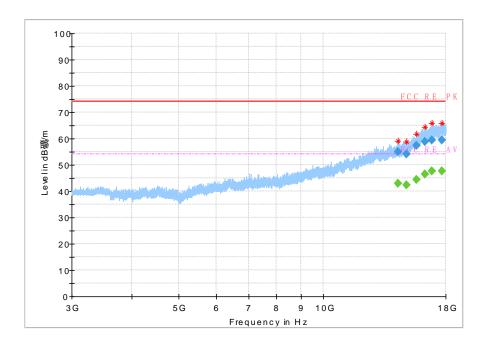


Fig.38 Radiated emission: $\pi/4$ DQPSK, Ch0, 3GHz~18GHz

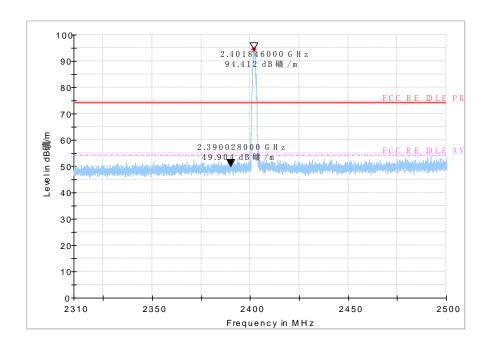


Fig.39 Bandedge (Low): π/4 DQPSK, low channel



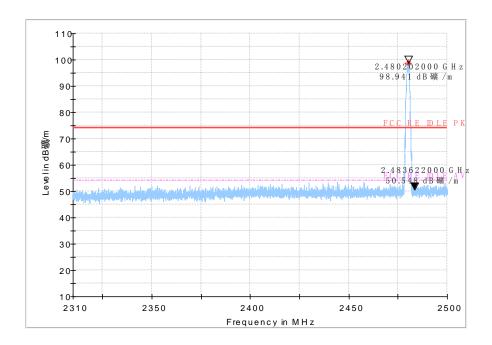


Fig.40 Bandedge (High): π/4 DQPSK, high channel

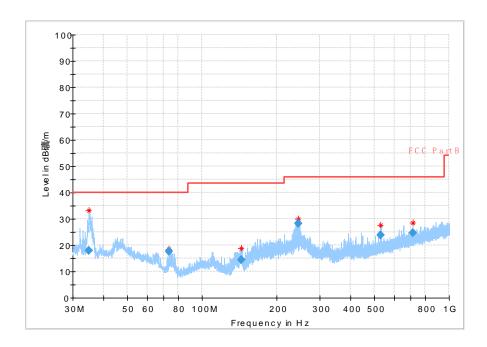


Fig.41 Radiated emission: 8DPSK, Ch0, 30MHz~1GHz



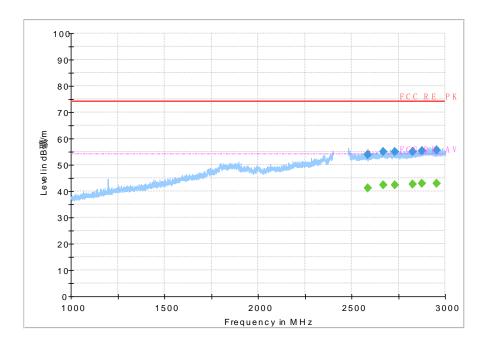


Fig.42 Radiated emission: 8DPSK, Ch0, 1GHz~3GHz

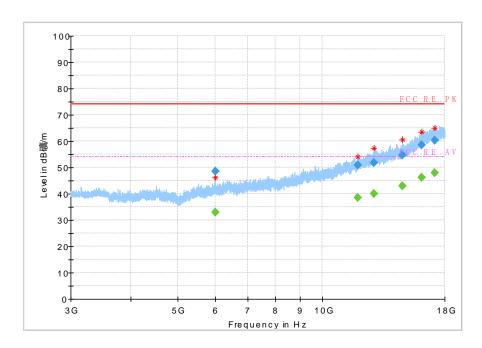


Fig.43 Radiated emission: 8DPSK, Ch0, 3GHz~18GHz



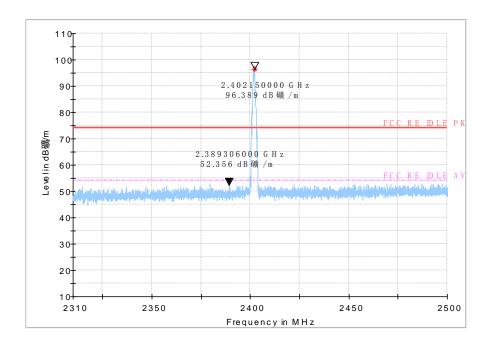


Fig.44 Bandedge (Low): 8DPSK, low channel

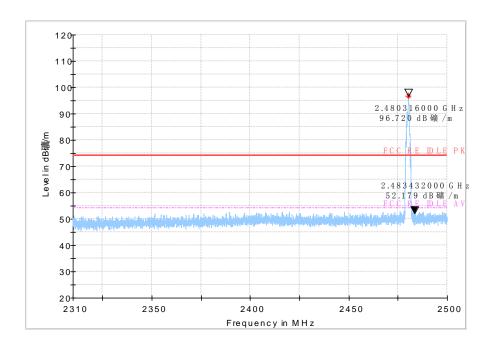
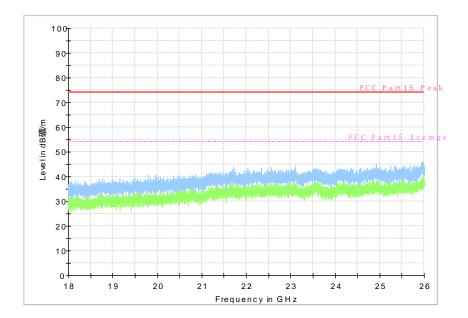


Fig.45 Bandedge (High): 8DPSK, high channel





ALL Channel 18GHz~26GHz



ANNEX A.5. Time Of Occupancy (Dwell Time)

A.5.1 Measurement Limit:

Standard	Limit (ms)
FCC 47CFR Part 15.247 (a) (1) (iii)	< 400

A.5.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.4

- 1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
- 2. Enable the EUT transmit maximum power.
- 3. Set the spectrum analyzer as step 4 to step 8.
- 4. Span: Zero span, centered on a hopping channel.
- 5. RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel.
- 6. Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to showtwo successive hops on a channel.
- 7. Detector function: Peak.
- 8. Trace: Max hold.
- 9. Use the marker-delta function, and record it.

Note: For AFH mode, Test Period = 0.4 (second/ channel) x 20 Channel = 8 sec,

For FHSS mode, Test Period = 0.4 (second/ channel) x 79 Channel = 31.6 sec,

So the Time of Occupancy (Dwell Time) of AFH mode= Time of Occupancy (Dwell Time) of FHSS mode / 79 Channel x 20 Channel

Modulation type	Frequency(MHz)	Dwell Time (ms)	Limit(ms)	Conclusion
AFH(GFSK DH5)	2402-2421MHz	57.92	400	Р
AFH(π/4 DQPSK DH5)	2402-2421MHz	63.78	400	Р
AFH(8DPSK DH5)	2402-2421MHz	63.43	400	Р



Measurement Result

For GFSK

Channel	Packet	Dwell Time (ms)		Conclusion	
	DH1	Fig.46	62.26	P	
		Fig.47	63.36	r	
39	DH3	Fig.48	195.84	P	
39	рпэ	Fig.49	195.64	F	
	DUE	Fig.50	220 70	D	
	DH5	Fig.51	228.78	228.78 P	r P

For $\pi/4$ DQPSK

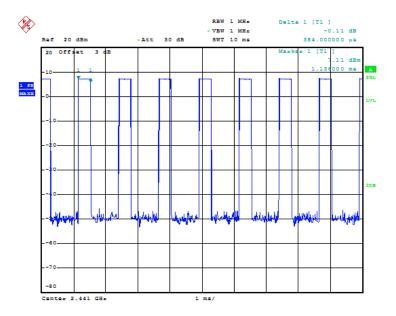
Channel	Packet	Dwell Time (ms)		Conclusion
	2DH1	Fig.52	00	
		Fig.53	66	Р
39	2DH3	Fig.54	199.1	P
39		Fig.55		F
	2DH5	Fig.56	251.95	Р
		Fig.57		r

For 8DPSK

Channel	Packet	Dwell Time (ms)		Conclusion
	3DH1	Fig.58	66	D
		Fig.59		Р
39	3DH3	Fig.60	199.1	P
39		Fig.61		Г
	3DH5	Fig.62	250.56	D
		Fig.63		250.56 P

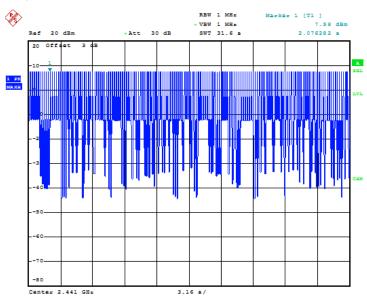
Conclusion: PASS
Test graphs as below:





Date: 29.JUL.2019 10:51:58

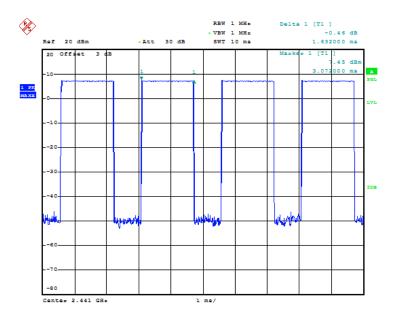
Fig.46 Time of occupancy (Dwell Time): Ch39, Packet DH1



Date: 29.JUL.2019 10:52:56

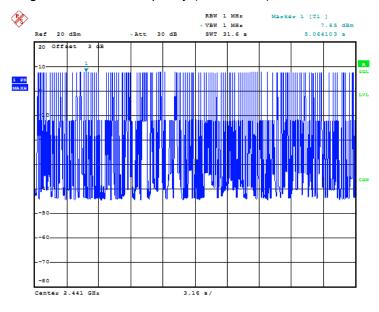
Fig.47 Number of Transmissions Measurement: Ch39, Packet DH1





Date: 29.JUL.2019 11:02:28

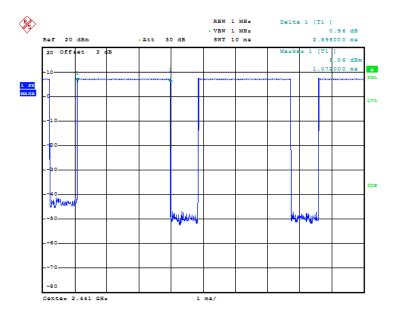
Fig.48 Time of occupancy (Dwell Time): Ch39, Packet DH3



Date: 29.JUL.2019 11:03:20

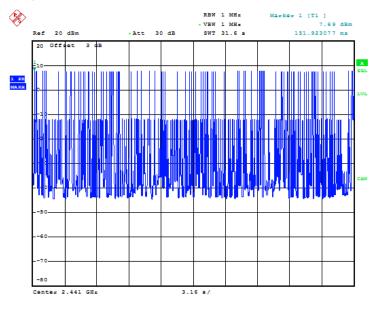
Fig.49 Number of Transmissions Measurement: Ch39, Packet DH3





Date: 29.JUL.2019 11:21:14

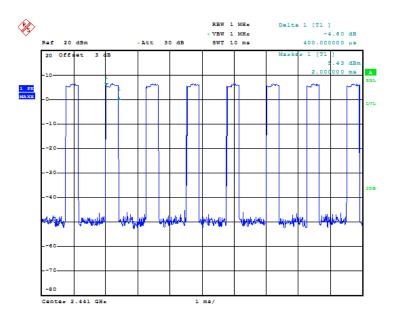
Fig.50 Time of occupancy (Dwell Time): Ch39,Packet DH5



Date: 29.JUL.2019 11:22:09

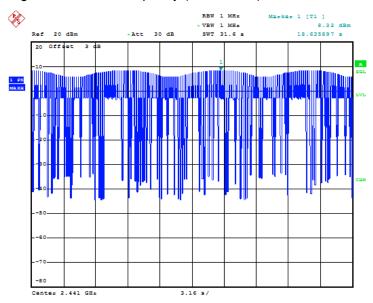
Fig.51 Number of Transmissions Measurement: Ch39, Packet DH5





Date: 29.JUL.2019 11:05:07

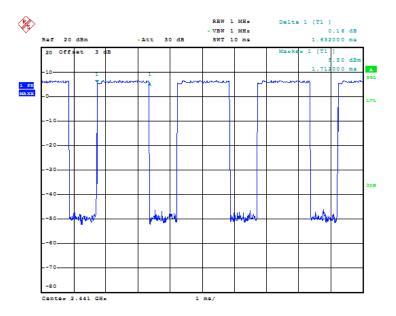
Fig.52 Time of occupancy (Dwell Time): Ch39, Packet 2-DH1



Date: 29.JUL.2019 11:06:05

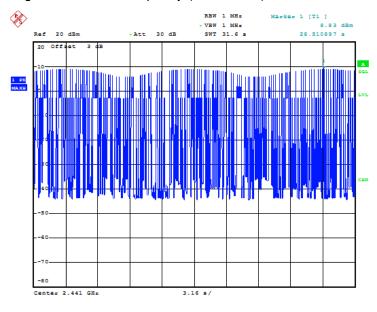
Fig.53 Number of Transmissions Measurement: Ch39, Packet 2-DH1





Date: 29.JUL.2019 11:31:05

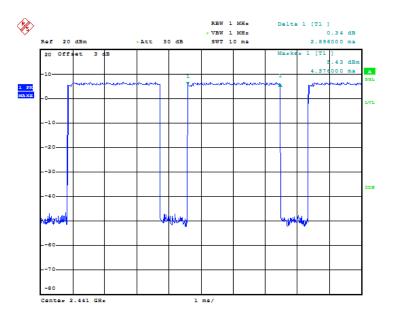
Fig.54 Time of occupancy (Dwell Time): Ch39, Packet 2-DH3



Date: 29.JUL.2019 11:32:43

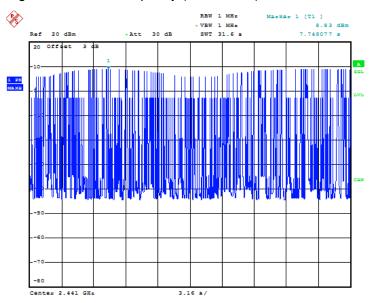
Fig.55 Number of Transmissions Measurement: Ch39, Packet 2-DH3





Date: 29.JUL.2019 11:09:48

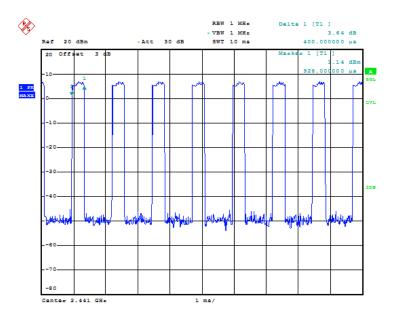
Fig.56 Time of occupancy (Dwell Time): Ch39, Packet 2-DH5



Date: 29.JUL.2019 11:10:42

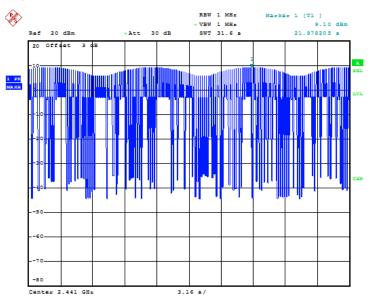
Fig.57 Number of Transmissions Measurement: Ch39, Packet 2-DH5





Date: 29.JUL.2019 11:11:20

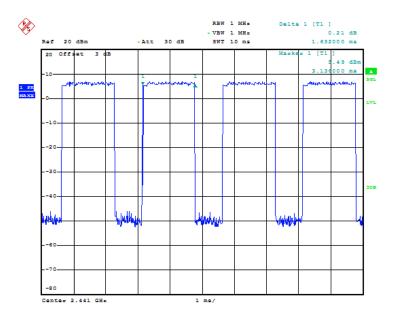
Fig.58 Time of occupancy (Dwell Time): Ch39,Packet 3-DH1



Date: 29.JUL.2019 11:12:12

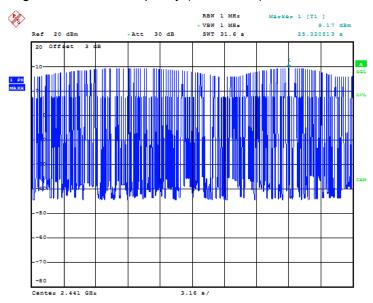
Fig.59 Number of Transmissions Measurement: Ch39, Packet 3-DH1





Date: 29.JUL.2019 11:35:49

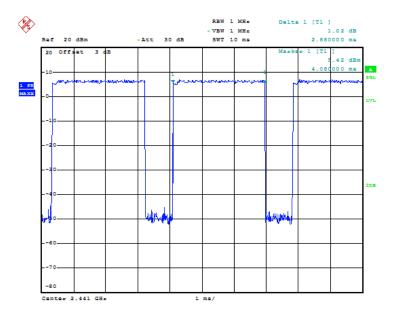
Fig.60 Time of occupancy (Dwell Time): Ch39, Packet 3-DH3



Date: 29.JUL.2019 11:36:43

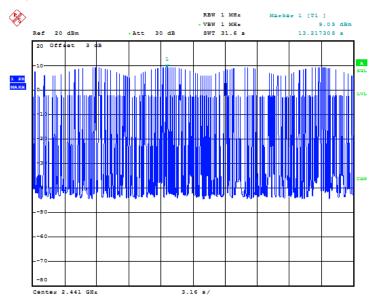
Fig.61 Number of Transmissions Measurement: Ch39, Packet 3-DH3





Date: 29.JUL.2019 11:14:35

Fig.62 Time of occupancy (Dwell Time): Ch39, Packet 3-DH5



Date: 29.JUL.2019 11:15:32

Fig.63 Number of Transmissions Measurement: Ch39, Packet 3-DH5



ANNEX A.6. 20dB Bandwidth

A.6.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (a) (1)	N/A

A.6.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.7

- 1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
- 2. Enable the EUT transmit maximum power.
- 3. Set the spectrum analyzer as step 4 to step 7.
- 4. Span: two or five times of OBW
- 5. RBW= 1% to 5% of the OBW; VBW is approximately three times of RBW; Max Hold.
- 6. Select the max peak, and N DB DOWN=20dB.
- 7. Record the results.

Measurement Result:

For GFSK

Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.64	0.774	Р
39	Fig.65	0.778	Р
78	Fig.66	0.807	Р

For π/4 DQPSK

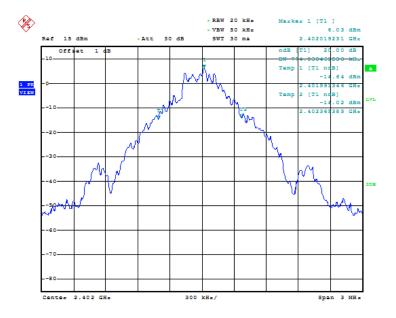
Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.67	1.250	Р
39	Fig.68	1.250	Р
78	Fig.69	1.250	Р

For 8DPSK

Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.70	1.206	Р
39	Fig.71	1.211	Р
78	Fig.72	1.211	Р

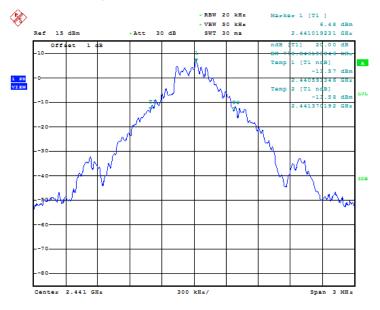
Conclusion: PASS
Test graphs as below:





Date: 23.JUL.2019 03:59:48

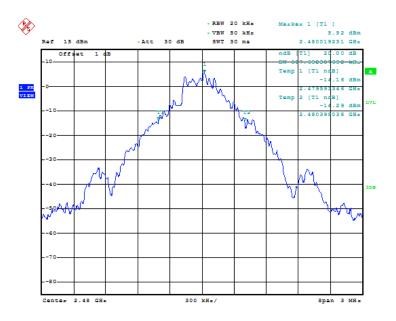
Fig.64 20dB Bandwidth: GFSK, Ch0



Date: 23.JUL.2019 04:05:11

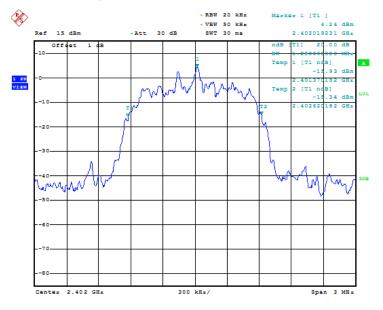
Fig.65 20dB Bandwidth: GFSK, Ch39





Date: 23.JUL.2019 04:07:26

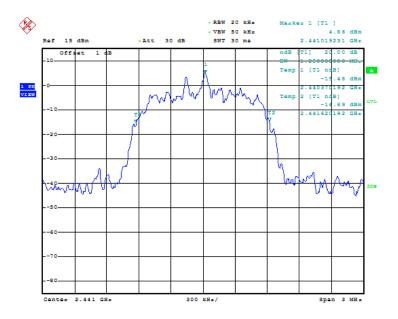
Fig.66 20dB Bandwidth: GFSK, Ch78



Date: 23.JUL.2019 04:09:35

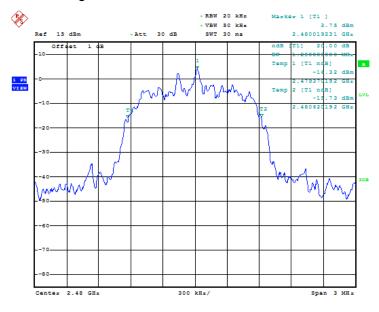
Fig.67 20dB Bandwidth: $\pi/4$ DQPSK, Ch0





Date: 23.JUL.2019 04:11:13

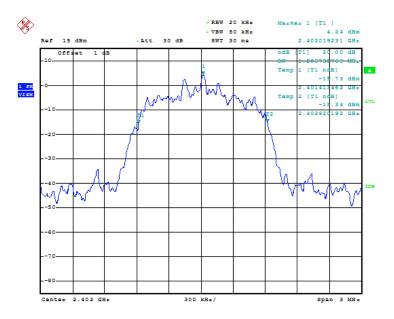
Fig.68 20dB Bandwidth: π/4 DQPSK, Ch39



Date: 23.JUL.2019 04:12:24

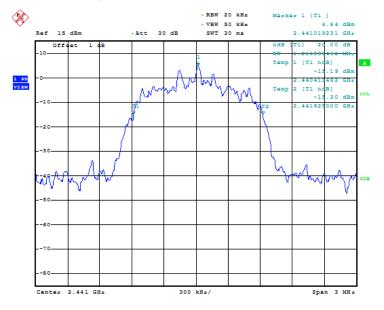
Fig.69 20dB Bandwidth: $\pi/4$ DQPSK, Ch78





Date: 23.JUL.2019 04:15:03

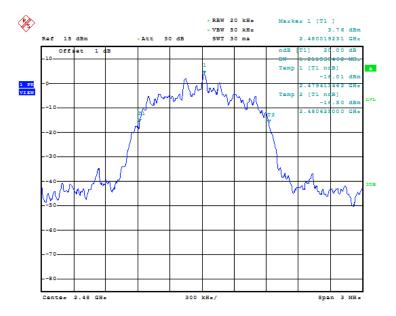
Fig.70 20dB Bandwidth: 8DPSK, Ch0



Date: 23.JUL.2019 04:16:29

Fig.71 20dB Bandwidth: 8DPSK, Ch39





Date: 23.JUL.2019 04:17:56

Fig.72 20dB Bandwidth: 8DPSK, Ch78



ANNEX A.7. Carrier Frequency Separation

A.7.1 Measurement Limit:

Standard	Limit (KHz)
FCC 47 CFR Part 15.247 (a) (1)	Over 25KHz or (2/3)*20dB bandwidth

A.7.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.2.

- 1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
- 2. Enable the EUT transmit in hopping mode.
- 3. Span: Wide enough to capture the peaks of two adjacent channels.
- 4. RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.
- 5. Video (or average) bandwidth (VBW) ≥ RBW.
- 6. Sweep: Auto.
- 7. Detector function: Peak.
- 8. Trace: Max hold.
- 9. Allow the trace to stabilize.

Measurement Result:

For GFSK

Channel	Carrier separation (KHz)		Conclusion
39	Fig.73	1008	Р

For π/4 DQPSK

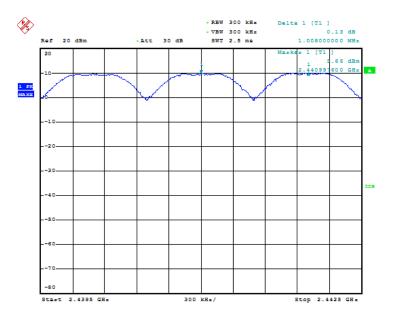
Channel	Carrier separation (KHz)		Conclusion
39	Fig.74	1027.2	Р

For 8DPSK

Channel	Carrier separation (KHz)		Conclusion
39	Fig.75	1012.8	Р

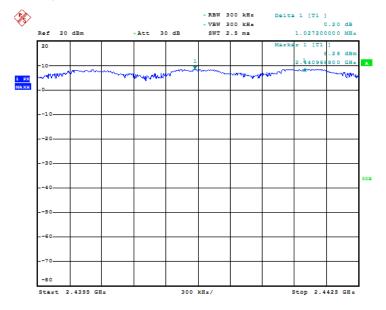
Conclusion: PASS
Test graphs as below:





Date: 19.AUG.2019 03:49:02

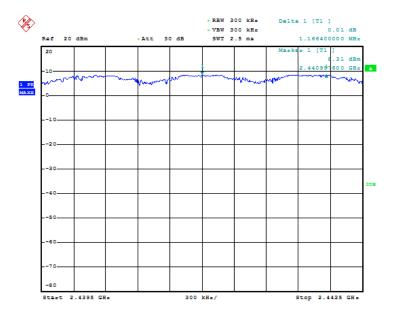
Fig.73 Carrier separation measurement: GFSK, Ch39



Date: 19.AUG.2019 03:40:59

Fig.74 Carrier separation measurement: π/4 DQPSK, Ch39





Date: 19.AUG.2019 03:42:24

Fig.75 Carrier separation measurement: 8DPSK, Ch39

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ANNEX A.8. Number Of Hopping Channels

A.8.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (a)(1)(iii)	At least 15 non-overlapping channels

A.8.2 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.3.

- 1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
- 2. Enable the EUT transmit in hopping mode.
- 3. Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.
- 4. RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
- 5. VBW \geq RBW.
- 6. Sweep: Auto.
- 7. Detector function: Peak.
- 8. Trace: Max hold.
- 9. Allow the trace to stabilize.
- 10. Record the test rsults.

Measurement Result:

For GFSK

Channel	Number of hopping channels		Conclusion
0~39	Fig.76	70	Р
40~78	Fig.77	79	Р

For $\pi/4$ DQPSK

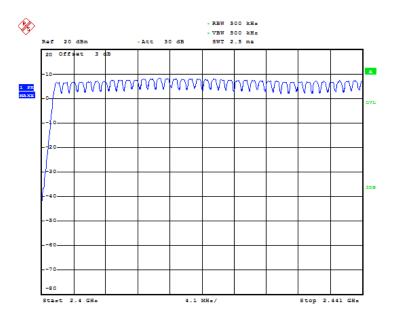
Channel	Number of hopping channels		Conclusion
0~39	Fig.78	79	Р
40~78	Fig.79		Р

For 8DPSK

Channel	Number of hopping channels		Conclusion
0~39	Fig.80	79	Р
40~78	Fig.81		Р

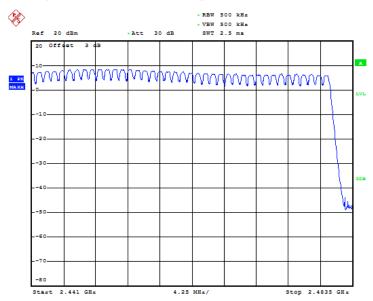
Conclusion: PASS
Test graphs as below:





Date: 29.JUL.2019 11:40:00

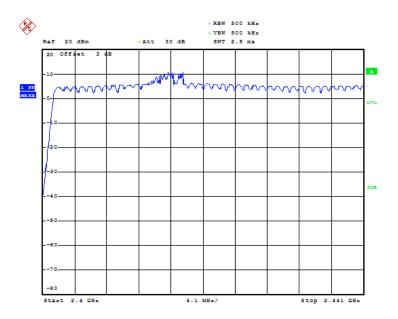
Fig.76 Number of hopping frequency: GFSK, Ch0~39



Date: 29.JUL.2019 11:41:08

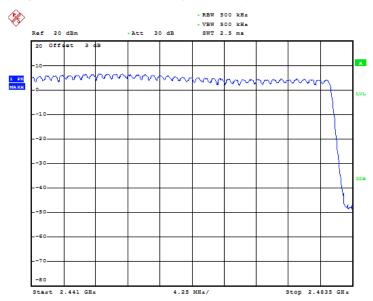
Fig.77 Number of hopping frequency: GFSK, Ch40~78





Date: 29.JUL.2019 11:43:39

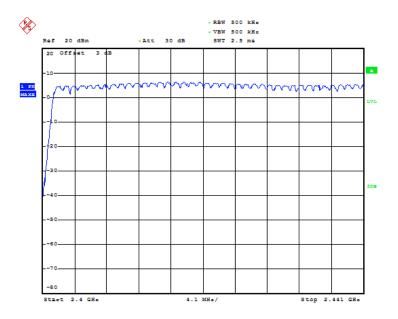
Fig.78 Number of hopping frequency: $\pi/4$ DQPSK, Ch0~39



Date: 29.JUL.2019 11:44:48

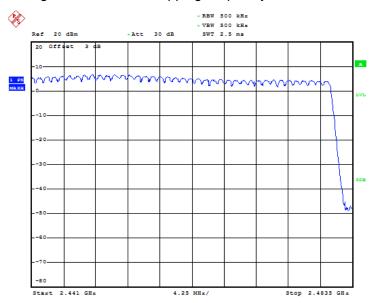
Fig.79 Number of hopping frequency: $\pi/4$ DQPSK, Ch40~78





Date: 29.JUL.2019 11:47:41

Fig.80 Number of hopping frequency: 8DPSK, Ch0~39



Date: 29.JUL.2019 11:48:49

Fig.81 Number of hopping frequency: 8DPSK, Ch40~78



ANNEX B. Accreditation Certificate





Accredited Laboratory

A2LA has accredited

EAST CHINA INSTITUTE OF TELECOMMUNICATIONS

Shanghai, People's Republic of China

for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017

General requirements for the competence of testing and calibration laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 6th day of May 2019.

Vice President, Accreditation Services For the Accreditation Council Certificate Number 3682.01 Valid to February 28, 2021

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For the tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation.

********END OF REPORT*******